IN THE CLAIMS:

Amendments to the Claims

Please amend claims 1, 2, 12 and 14 as shown below.

Listing of Claims:

This listing of claims will replace all prior versions, and listings, of claims in the application:

- 1. (currently amended) An optical apparatus comprising:
- a metal member that is disposed on a substrate and has a tip part;
- a light source device;
- <u>a polarization modulator</u> for modulating the <u>a</u> direction of polarization <u>of light</u> <u>from said light source</u>;

an optical member for irradiating the tip part of said metal member with light from said polarization modulator so as to generate light-source device; a detector for illuminating a sample with the near-field light generated at around the tip part of said metal member; and

a mechanism for controlling distance between the tip part of the said metal member and an object;

<u>a detector for detecting either light having passed through said sample object</u> or light reflected or scattered by said sample object; and

a separator for extracting a signal that is synchronized with said polarization modulation from an electric signal outputted from said detector.

- 2. (currently amended) An optical apparatus that uses the near-field light, comprising:
 - a light source device;

<u>a polarization modulator</u> for modulating the <u>a</u> direction of polarization <u>of light</u> from said light source;

a probe that was provided with one or more metal members each having a tip part;

a sample support for holding a sample;

an optical member for irradiating the tip part of the metal member of said probe with light from said polarization modulator so as to generate the near-field light around the tip part of said metal member;

a distance controller for controlling the distance between said sample and said probe to make said sample be illuminated by the near-field light;

an optical member for irradiating the tip part of the metal member of said probe with light from said light source device;

at least one detector for illuminating said sample with the near-field light generated from said probe and detecting signal light radiated from said sample detecting light having passed through said sample or light reflected or scattered by said sample or light redirected from said sample;

at least one separator for separating and detecting extracting a signal that is synchronized with the polarization modulation of said-light source device from the an electric signal outputted from said at least one detector; and

a signal processor for processing the \underline{a} signal from said at least one separator.

3. (Previously Presented) An optical apparatus that uses the near-field light according to claim 1 or claim 2, wherein the optical apparatus is constructed in such a manner that direction of polarization of light that irradiates the tip part of said metal member is switchable either to linearly polarized light parallel to a direction of

the point of said metal member or linearly polarized light orthogonal to the direction of the point by said light source device.

- 4. (Previously Presented) An optical apparatus that uses the near-field light according to claim 1 or claim 2, wherein an apex angle of the tip part of said metal member is 90 degrees.
- 5. (Original) An optical apparatus that uses the near-field light according to claim 1 or claim 2, wherein a polarization compensator whose transmittance or reflectance is different depending on the polarization is disposed on an optical path of said optical member to effect compensation of polarization characteristics of other optical components.
- 6. (Previously Presented) An optical apparatus that uses the near-field light according to claim 5, wherein said polarization compensator is composed of a glass plate disposed so that a normal thereto is slanted to an optical axis of said optical member.
- 7. (Original) An optical apparatus that uses the near-field light according to claim 2, wherein said probe has the shape of a multiangular pyramid or the shape of a cone with one face thereof or opposing two faces thereof being provided with said metal member.
- 8. (Previously Presented) An optical device that uses the near-field light according to claim 1, wherein said sample is a recording medium and said metal member having the tip part disposed on said substrate is composed in a planar shape.

- 9. (Previously Present d) An optical apparatus that uses the near-field light according to claim 7, wherein faces of said probe other than faces on which said metal member is provided are coated with a predetermined metal and at the same time a gap smaller than a half-wavelength of the light of said light source device is provided on the tip part thereof.
- 10. (original) An optical apparatus that uses the near-field light according to claim 9, wherein said predetermined metal used for coating is a metal different from said metal member.
- 11. (Original) An optical apparatus that uses the near-field light according to claim 7, wherein the thickness of said metal member that is provided on said probe is controlled to a predetermined thickness and thereby the optical apparatus is constructed in such a manner that the optical signal that has passed through said probe as propagating light and is detected by said detector is suppressed.
 - 12. (Currently Amended) An optical apparatus comprising:

a metal member disposed on a substrate so as to have at least one tip part and delimiting a narrow gap and a wide gap in orthogonal directions to one another;

a light source device which enables modulation of;

<u>a polarization modulator which modulates</u> a direction of polarization of light from said light source;

an optical member for irradiating the gaps narrow gap and the tip part with light from the light source device through said polarization modulator;

a detector for detecting at least one of light having passed through a sample an object and light at least one of reflected and scattered by the sample object;

wherein a direction of polarization of incident light is modulated according to the orthogonal directions and an intensity of detected light is subjected to

synchronous signal detection with the modulation so that signals resulting from background light are removable and only a near-field light signal is extracted.

- 13. (Previously Presented) An optical apparatus that uses near-field light, comprising:
 - a light source device;
 - a probe provided with at least one metal member having a tip part;
 - a sample support for holding a sample;
- a distance controller for controlling a distance between the sample and the probe;
- a polarization modulator for modulating a direction of polarization of light from the light source device between orthogonal directions in which one of the directions is parallel to a direction of the end of the tip part of the metal member and the other direction is orthogonal thereto;

an optical member for irradiating the tip part of the metal member of the probe with light from the polarization modulator;

at least one detector for detecting signal light at least one of radiated from the sample and at least one of reflected and scattered by the sample;

at least one separator for removing a signal caused by background light and extracting only a signal of the near-field light from the signal outputted from the at least one detector; and

a signal processor for processing the signal from the at least one separator.

14. (Currently Amended) A probe method using a near-field optical microscope, comprising the steps of:

providing a probe including a metal member disposed on a substrate so as to have a narrow gap extending in one direction and a wide gap extending in an orthogonal direction;

providing a light source; device

providing a polarization modulator for modulating a direction of polarization of light from said light source and illuminating a sample with the near-field-light generated at the gaps;

providing an optical member for irradiating the gaps with light from the said light source device;

providing a detector for detecting light at least one of having passed through the \underline{a} sample and at least one of reflected and scattered by the sample; and

modulating a direction of polarization of the incident light to the directions of the gaps and detecting an intensity of the detected light which is subjected to a synchronous signal detection with the modulation so that a signal resulting from background light is removable and only the near-field light signal is extracted.